Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/682,645	KAHN, JESSICA
Examiner	Art Unit
TuyetLien (Lien) T. Tran	2179

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
Attached EAST search history	2/16/2007	π
Consulted with Ba Huynh	2/16/2007	т
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